

**TRANSMITTAL LETTER TO THE UNITED STATES
DESIGNATED/ELECTED OFFICE (DO/EO/US)
CONCERNING A FILING UNDER 35 U.S.C. 371**

TNG-3-US

U.S. APPLICATION NO. (IF KNOWN, SEE 37 CFR

09/807819

INTERNATIONAL APPLICATION NO.

PCT/JP00/05587

INTERNATIONAL FILING DATE

August 21, 2000

PRIORITY DATE CLAIMED

August 20, 1999

TITLE OF INVENTION

DIELECTRIC RESONATOR AND DIELECTRIC FILTER

APPLICANT(S) FOR DO/EO/US

Akihiro Isomura, Atsushi Furuta and Jae-Ho Hwang

Applicant herewith submits to the United States Designated/Elected Office (DO/EO/US) the following items and other information:

1. ☒ This is a **FIRST** submission of items concerning a filing under 35 U.S.C. 371.
2. ☐ This is a **SECOND** or **SUBSEQUENT** submission of items concerning a filing under 35 U.S.C. 371.
3. ☒ This is an express request to begin national examination procedures (35 U.S.C. 371(f)) at any time rather than delay examination until the expiration of the applicable time limit set in 35 U.S.C. 371(b) and PCT Articles 22 and 39(1).
4. ☐ A proper Demand for International Preliminary Examination was made by the 19th month from the earliest claimed priority date.
5. ☒ A copy of the International Application as filed (35 U.S.C. 371 (c) (2))
 - a. ☐ is transmitted herewith (required only if not transmitted by the International Bureau).
 - b. ☒ has been transmitted by the International Bureau.
 - c. ☐ is not required, as the application was filed in the United States Receiving Office (RO/US).
6. ☒ A translation of the International Application into English (35 U.S.C. 371(c)(2)).
7. ☐ A copy of the International Search Report (PCT/ISA/210).
8. ☒ Amendments to the claims of the International Application under PCT Article 19 (35 U.S.C. 371 (c)(3))
 - a. ☐ are transmitted herewith (required only if not transmitted by the International Bureau).
 - b. ☐ have been transmitted by the International Bureau.
 - c. ☐ have not been made; however, the time limit for making such amendments has NOT expired.
 - d. ☒ have not been made and will not be made.
9. ☐ A translation of the amendments to the claims under PCT Article 19 (35 U.S.C. 371(c)(3)).
10. ☒ An oath or declaration of the inventor(s) (35 U.S.C. 371 (c)(4)).
11. ☐ A copy of the International Preliminary Examination Report (PCT/IPEA/409).
12. ☐ A translation of the annexes to the International Preliminary Examination Report under PCT Article 36 (35 U.S.C. 371 (c)(5)).

Items 13 to 20 below concern document(s) or information included:

13. ☐ An Information Disclosure Statement under 37 CFR 1.97 and 1.98.
14. ☐ An assignment document for recording. A separate cover sheet in compliance with 37 CFR 3.28 and 3.31 is included.
15. ☒ A **FIRST** preliminary amendment.
16. ☐ A **SECOND** or **SUBSEQUENT** preliminary amendment.
17. ☐ A substitute specification.
18. ☐ A change of power of attorney and/or address letter.
19. ☐ Certificate of Mailing by Express Mail
20. ☒ Other items or information:

Request for PCT Application (Form PCT/RO/101)**International Publication WO 01/15262 A1****19 sheets of informal drawings (figs. 1-24)**

U.S. APPLICATION NO. (IF KNOWN) SEE 37 CFR

INTERNATIONAL APPLICATION NO.

ATTORNEY'S DOCKET NUMBER

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21. The following fees are submitted:

BASIC NATIONAL FEE (37 CFR 1.492 (a) (1) - (5)) :

- ☐ Neither international preliminary examination fee (37 CFR 1.482) nor international search fee (37 CFR 1.445(a)(2)) paid to USPTO and International Search Report not prepared by the EPO or JPO \$1,000.00
- ☒ International preliminary examination fee (37 CFR 1.482) not paid to USPTO but International Search Report prepared by the EPO or JPO \$860.00
- ☐ International preliminary examination fee (37 CFR 1.482) not paid to USPTO but international search fee (37 CFR 1.445(a)(2)) paid to USPTO \$710.00
- ☐ International preliminary examination fee paid to USPTO (37 CFR 1.482) but all claims did not satisfy provisions of PCT Article 33(1)-(4) \$690.00
- ☐ International preliminary examination fee paid to USPTO (37 CFR 1.482) and all claims satisfied provisions of PCT Article 33(1)-(4) \$100.00

ENTER APPROPRIATE BASIC FEE AMOUNT =

\$860.00

Surcharge of **\$130.00** for furnishing the oath or declaration later than ☒ 20 ☐ 30 months from the earliest claimed priority date (37 CFR 1.492 (e)).

\$130.00

CLAIMS	NUMBER FILED	NUMBER EXTRA	RATE	
Total claims	20 - 20 =	0	x \$18.00	\$0.00
Independent claims	2 - 3 =	0	x \$80.00	\$0.00

Multiple Dependent Claims (check if applicable). ☐ \$0.00

TOTAL OF ABOVE CALCULATIONS = \$990.00

Reduction of 1/2 for filing by small entity, if applicable. Verified Small Entity Statement must also be filed (Note 37 CFR 1.9, 1.27, 1.28) (check if applicable). ☐ \$0.00

SUBTOTAL = \$990.00

Processing fee of **\$130.00** for furnishing the English translation later than ☐ 20 ☐ 30 months from the earliest claimed priority date (37 CFR 1.492 (f)).

\$0.00

TOTAL NATIONAL FEE = \$990.00

Fee for recording the enclosed assignment (37 CFR 1.21(h)). The assignment must be accompanied by an appropriate cover sheet (37 CFR 3.28, 3.31) (check if applicable). ☐ \$0.00

TOTAL FEES ENCLOSED = \$990.00

Amount to be:	\$
refunded	
charged	\$

☒ A check in the amount of **\$990.00** to cover the above fees is enclosed.

☐ Please charge my Deposit Account No. _____ in the amount of _____ to cover the above fees.
A duplicate copy of this sheet is enclosed.

☒ The Commissioner is hereby authorized to charge any fees which may be required, or credit any overpayment to Deposit Account No. **50-0481** A duplicate copy of this sheet is enclosed.

NOTE: Where an appropriate time limit under 37 CFR 1.494 or 1.495 has not been met, a petition to revive (37 CFR 1.137(a) or (b)) must be filed and granted to restore the application to pending status.

SEND ALL CORRESPONDENCE TO:

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NAME

34,386

REGISTRATION NUMBER

April 19, 2001

DATE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Isomura et al.

Serial No.: Not Yet Assigned

Group Art Unit: Not Yet Assigned

Filing Date: Concurrently Herewith

Examiner: Unknown

For: DIELECTRIC RESONATOR AND DIELECTRIC FILTER

Assistant Commissioner of Patents
Washington, D.C. 20231

PRELIMINARY AMENDMENT

Sir:

Prior to examination on the merits and calculation of the filing fee, please amend the above-identified application as follows:

IN THE CLAIMS:

Please amend claims 4 and 5 as follows:

4. (Amended) A dielectric filter claimed in claim 2 characterized in disposing a metal rod contacting with said cut-off waveguide by one end in parallel with a side surface of said dielectric resonator in the position distant by a predetermined amount from said side surface and having a composition in which resonant frequency of each resonance and an amount of coupling between resonators is adjustable.
5. (Amended) A dielectric filter claimed in claim 2 characterized in installing another resonator further than said dielectric resonator in said cut-off waveguide.

Please add the following new claims:

17. (New) A dielectric filter claimed in claim 3 characterized in disposing a metal rod contacting with said cut-off waveguide by one end in parallel with a side surface of said dielectric resonator in the position distant by a predetermined amount from said side surface and having a composition in which resonant frequency of each resonance and an amount of coupling between resonators is adjustable.

18. (New) A dielectric filter claimed in claim 1 characterized in installing another resonator further than said dielectric resonator in said cut-off waveguide.

19. (New) A dielectric filter claimed in claim 3 characterized in installing another resonator further than said dielectric resonator in said cut-off waveguide.

20. (New) A dielectric filter claimed in claim 4 characterized in installing another resonator further than said dielectric resonator in said cut-off waveguide.

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REMARKS


The above changes to the claims have been made, and new claims have been added, to delete the multiple-dependency of the claims.

No new matter has been added.

Attached hereto is a marked-up version of the changes made to the claims by the current preliminary amendment. The attached page is captioned "**Version with markings to show changes made.**"

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's Deposit Account No. 50-0481.

Respectfully submitted,



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Date: 4/19/01

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VERSION WITH MARKINGS TO SHOW CHANGES MADE**IN THE CLAIMS:**

Claims 4 and 5 have been amended as follows:

4. (Amended) A dielectric filter claimed in claim 2 [or 3] characterized in disposing a metal rod contacting with said cut-off waveguide by one end in parallel with a side surface of said dielectric resonator in the position distant by a predetermined amount from said side surface and having a composition in which resonant frequency of each resonance and an amount of coupling between resonators is adjustable.

5. (Amended) A dielectric filter claimed in claim 2 [through 4] characterized in installing [other] another resonator further than said dielectric resonator [claimed in claim 1] in said cut-off waveguide.

Please add the following new claims:

17. (New) A dielectric filter claimed in claim 3 characterized in disposing a metal rod contacting with said cut-off waveguide by one end in parallel with a side surface of said dielectric resonator in the position distant by a predetermined amount from said side surface and having a composition in which resonant frequency of each resonance and an amount of coupling between resonators is adjustable.

18. (New) A dielectric filter claimed in claim 1 characterized in installing another resonator

further than said dielectric resonator in said cut-off waveguide.

19. (New) A dielectric filter claimed in claim 3 characterized in installing another resonator further than said dielectric resonator in said cut-off waveguide.

20. (New) A dielectric filter claimed in claim 4 characterized in installing another resonator further than said dielectric resonator in said cut-off waveguide.

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JC02 Rec'd PCT/PTO 1 9 APR 2001

SPECIFICATIONS

DIELECTRIC RESONATOR AND DIELECTRIC FILTER

5 [Technical Field]

The present invention relates to a dielectric filter used in radio communications, and the like at high frequency band as microwave band, quasi-microwave band, and the like and a dielectric resonator used in the dielectric filter, and more particularly to a triple mode dielectric resonator in which three resonant modes are available in one dielectric block and a dielectric filter using the dielectric resonator therein.

[Technical Background]

Conventionally, a dielectric filter which providing a cut-off waveguide with cylindrical or rectangular parallelepiped dielectrics disposing successively therein and utilizing resonance of a cylindrical $TE_{01\delta}$ mode or a rectangular $TE_{11\delta}$ mode of dielectrics is utilized widely in filters requiring low loss and size reduction, because the dielectric filter has high unloaded Q and can be reduced in size easier than waveguide type filter (a first conventional example). A resonance of the mode is generated by an electric field repeating reflections at an interface surface of the dielectric resonator and the air. The resonant frequency of dielectric resonator is inversely proportional to the length of the resonator and square root of dielectric constant, so that the larger the dielectric constant is, the smaller the resonator is. And a magnetic field generated by the resonance excites a resonator on the next stage and the excitation corresponds to the coupling between stages of the

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dielectric filter. As a magnitude of the coupling is mainly determined by the distance between resonators, the farther the distance is, the weaker the coupling is. As adjusting means for the above-mentioned dielectric filter, a method of adjusting the resonant frequency by a screw in a direction orthogonal to the reflecting surface of the magnetic field or a method of adjusting the coupling between the resonators by a screw, and the like are adoptable.

And there is also a dielectric filter utilizing a dual mode dielectric resonator in order to achieve size reduction (a second conventional example). The above-mentioned dielectric resonator provides two resonance by one resonator, in which a cylindrical dielectric resonator is disposed in the center of a cylindrical waveguide by justifying the axes of the cylinders, for example, and two resonance ($HE_{11} \delta$) generated in two directions orthogonal to the axes of the cylinders are coupled by disturbing the electromagnetic field of the resonance from the waveguide side using means as screws, and the like.

As the description about a first conventional example above, the resonant frequency of the resonator by a cylindrical $TE_{01} \delta$ mode or a rectangular $TE_{11} \delta$ mode of dielectrics depends on dielectric constant and the size of dielectrics and a resonator can be smaller when the dielectric constant gets larger, accordingly the simplest method of reducing size of the filter utilizing the dielectric resonator is to raise the dielectric constant of dielectrics.

However, as dielectrics with low dielectric loss used in microwave region generally has a characteristic that dielectric loss thereof increases as dielectric constant becomes higher,

size reduction of the filter maintaining insertion loss low has a certain limitation. Further, as dielectrics with low loss as mentioned above is expensive, accordingly the filter becomes expensive when the filter provides more stages, that is, provides more dielectrics used therein.

And a filter relative to a second conventional example utilizing $HE_{11}\delta$ dual mode dielectric resonator for size reduction has a problem that lots of undesired modes excited in the vicinity of pass band result in spurious characteristic deteriorated easily, because $HE_{11}\delta$ is not the dominant mode.

On the other hand, for example, in the event that a dielectric filter used in microwave communications, and the like is composed, it is conventionally hard to reduce size and weight of a dielectric filter, because many resonators and each spaces between the resonators occupies large amount of volume and weight according to the requirement of one resonator for one resonance and space for coupling between each resonator. Therefore, there still is a problem that the dielectric filter is unavoidably composed complicated and large, even though it is a band pass filter using dielectric resonators of relatively small size.

Consequently, composing a dielectric filter using dielectric resonators capable of multiple mode resonance is proposed to realize a band pass filter with a very small and simple composition exploiting advantages in using dielectric resonators fully. For example, size reduction of a band pass filter having a double-tuned band characteristic by varying the resonant frequency of the two resonance modes to each other is proposed in unexamined Japanese Patent Publication No. Hei

7-58516, in which degenerate coupling of two resonance modes with respect to TE₁₀₁ and TE_{01δ} modes is disclosed (a third conventional example). And a multiple mode dielectric resonator capable of generating TM_{01δ} mode and TE_{01δ} mode which are generated on a surface parallel to each surface (x-y surface, y-z surface, x-z surface) in a rectangular coordinate system in a generally rectangular parallelepiped shaped dielectric block is proposed in unexamined Japanese Patent Publication No. Hei 11-145704 (a fourth conventional example).

However, it is still unavoidable that a dielectric resonator occupies a large amount of volume in a band pass filter requiring a resonator of multiple stages, even though the degenerate coupling of two resonance modes relative to the above-mentioned third conventional example as described in unexamined Japanese Patent Publication No. Hei 7-58516 is utilized. And even a triple mode dielectric resonator relative to the fourth example as described in unexamined Japanese Patent Publication No. Hei 11-145704 has a problem that the manufacturing process becomes complicated, because utilization of hybrid coupling of TM_{01δ} mode and TE_{01δ} mode which are orthogonal spatially requires the thickness of dielectric resonator to be adjusted to resonant frequency.

It is therefore a first object of the present invention to realize a dielectric filter capable of reducing the number of dielectric resonators to a large extent, aiming at size reduction and cost reduction and providing favorable out-of-band characteristic by incorporating the mode which has been undesired into the band and activating the mode as a portion of

resonance necessary for filter characteristic exploiting advantages that unloaded Q of the dielectric filter by a cylindrical TE₀₁ δ mode or a rectangular TE₁₁ δ mode relative to a first and a second conventional examples is high.

5 And a second object of the present invention is to solve the problem of the above-mentioned third and fourth conventional examples and to provide a very small dielectric resonator with simple composition in spite of enabling a triple mode resonance and a dielectric filter using the above-mentioned dielectric resonator.

10 [Disclosure of the Invention]

The present invention aims at size reduction of dielectric filter by using three resonant modes in one dielectric block in order to achieve a first object of the above-mentioned present invention. That is, in a block of a generally rectangular parallelepiped consisting of dielectric material, three resonant modes in a single dielectric block can be coupled by chamfering a ridge portion of the dielectric block and another ridge portion unparallel thereto.

20 That is, the dielectric resonator claimed in claim 1 is characterized in combining three resonant modes of the above-mentioned dielectric block by removing one ridge portion and another ridge portion unparallel thereto in a block of a generally rectangular parallelepiped.

25 It is apparent from physical symmetry characteristics that a rectangular TE₁₁ δ mode can exist in each of three orthogonal axial direction in a block of a generally rectangular parallelepiped. In a conventional dielectric filter using TE₁₁

δ mode or $HE_{11\delta}$ mode, the filter is composed using only one or two resonance out of the above-mentioned resonance of three axial direction, while the rest of the resonance exerts a harmful effect as undesired resonance. In the present invention, the rest of the resonance is utilized positively so that one resonator acts as three resonators.

And a dielectric filter claimed in claim 2 is characterized in disposing at least one dielectric resonator claimed in claim 1 in a cut-off waveguide.

Because a small dielectric filter with low insertion loss can be manufactured by composing a filter in which one or more of the above-mentioned dielectric resonators are disposed in the cut-off waveguide.

Further, a dielectric filter claimed in claim 3 is characterized in disposing two or more of the above-mentioned dielectric resonators in the above-mentioned cut-off waveguide and providing means for partition consisting of electric conductive material between the above-mentioned dielectric resonators.

Because, in the event of using plural of resonators, it becomes possible to adjust the coupling of each mode between resonators properly, to take required coupling for the pass band characteristics and to form an attenuation pole out of the pass band by providing conductive partitions between each of the resonators.

And a dielectric filter claimed in claim 4 is characterized in disposing a metal rod contacting with the above-mentioned waveguide by one end parallel to a side surface of the above-mentioned dielectric resonator in a position away from the

above-mentioned side surface by a predetermined distance, in which resonant frequency of each resonance and the coupling between each of the resonance are adjustable depending on the length of the above-mentioned metal rod.

5 Because, a filter using a triple mode dielectric resonator according to the present invention is capable of adjusting resonant frequency and the amount of coupling by putting a metal rod as a screw from the cut-off waveguide parallel to the side surface of the dielectric resonator in the position away from
10 the side surface of the dielectric resonator by a predetermined distance and occupying adjustable range of the filter widely by combining above-mentioned operation with conventional means for adjusting.

Incidentally, a dielectric filter claimed in claim 5 is
15 characterized in further installing a resonator other than the dielectric resonator claimed in claim 1 in the above-mentioned waveguide as well.

Because, a small filter with an arbitrary number of stage can be composed by combining the triple mode dielectric resonator according to the present invention and resonators of dielectrics TE₀₁ δ mode or TEM mode by metallic conductor, and the like. Besides, out-of-band characteristics all over the filter can be improved by using a resonator with less undesired resonance or with undesired resonance located away from the
20 necessary band as the above-mentioned combined resonator.

On the other hand, in the present invention, a dielectric resonator is composed of a dielectric block of a generally rectangular parallelepiped with three ridge portions chamfered thereof and TE₀₁ δ mode is generated on the electro-

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magnetically individual three surfaces of the above-mentioned dielectric block as claimed in claim 6 in order to achieve the above-mentioned second object of the present invention.

Incidentally, it is preferable for the above-mentioned dielectric block to be mounted in a cut-off waveguide of a generally rectangular parallelepiped as claimed in claim 7.

And a dielectric resonator claimed in claim 8 is characterized in having three surfaces of A1, A2, A3 (hereafter called surfaces A) formed by chamfering three ridge portions sharing an apex of the above-mentioned dielectric block and three surfaces of B1, B2, B3 (hereafter called surfaces B) adjacent to each of the surfaces A respectively, in which an angle between 40 degrees and 50 degrees, both inclusive, is offered by the surfaces A and B and an area ratio of the above-mentioned surfaces A with respect to the surfaces B stands between 1% and 200%, both inclusive.

Further, a dielectric resonator claimed in claim 9 is characterized in having three surfaces A formed by chamfering three ridge portions sharing an apex of the above-mentioned dielectric block, another three surfaces of A'4, A'5, A'6 (hereafter called surfaces A') formed by chamfering three ridge portions sharing another apex on a diagonal line of the above-mentioned point, another three surfaces of B'1, B'2, B'3 (hereafter called surfaces B') adjacent to each of surfaces A and surfaces A' respectively and still another three surfaces of C'1 C'2 C'3 (hereafter called surfaces C') adjacent to each of surfaces A and surfaces A' respectively, in which an angle between 40 degrees and 50 degrees, both inclusive, is offered by the surfaces A and B' or by the surfaces A' and C' and an area

ratio of the above-mentioned surfaces A with respect to the above-mentioned surfaces B' or an area ratio of the above-mentioned surfaces A' with respect to the above-mentioned surfaces C' stand between 1% and 200%, both inclusive, respectively.

On the other hand, a dielectric filter claimed in claim 10 is a dielectric filter using a dielectric resonator, in which an angle between 40 degrees and 50 degrees, both inclusive, is offered by the above-mentioned three surfaces A or A' and other three surfaces B or B' adjacent thereto respectively and the surfaces A or A' and surfaces B or B' adjacent thereto respectively have three opposing surfaces of C1, C2, C3 (hereafter called surfaces C) or the surfaces C' and characterized in providing a feeding probe near the surfaces B and B', the surfaces B' and B', the surfaces C and C', or the surfaces C' and C'.

And a dielectric filter claimed in claim 11 is a dielectric filter using a dielectric resonator having the above-mentioned three surfaces A formed by chamfering three ridge portion sharing an apex of the above-mentioned dielectric block, another three surfaces B adjacent to the above-mentioned three surfaces A forming an angle of 40 degrees through 50 degrees and three surfaces C opposing to the above-mentioned three surfaces B respectively, in which a feeding probe is provided on the surfaces B and surfaces C.

Incidentally, as a dielectric filter claimed in claim 12, an angle offered by direction p and p' of the feeding probe with respect to the x, y, z axes of the above-mentioned dielectric resonator are variable within the range of -45 degrees through

+45 degrees while in use.

And as a dielectric filter claimed in claim 13, frequency and attenuation generating the attenuation pole at a lower side band can be varied by varying a position for providing a feeding probe on the above-mentioned surfaces B and a position for providing a feeding probe on the above-mentioned surfaces C respectively.

Here, either of rod-type as claimed in claim 14 or loop-type as claimed in claim 15 is acceptable as the above-mentioned feeding probe.

Further, as claimed in claim 16, a dielectric filter capable of being applied to various kinds of application can be composed by mounting two or more of the above-mentioned dielectric resonators in the above-mentioned cut-off waveguide of a generally rectangular parallelepiped therein.

[Brief Description of the Drawings]

Fig. 1 is a perspective diagram for showing a triple mode dielectric resonator relative to a first preferred embodiment of the present invention,

Fig. 2 is a diagram for illustrating resonance of rectangular TE_{110} mode, (a) is indicating a direction to which an electric field acts and (b) is indicating a direction to which a magnetic field acts respectively,

Fig. 3 is a diagram for illustrating the principle of a resonator which excites three resonance successively, (a) is indicating resonance of a direction z is on a first stage of a filter, (b) is indicating resonance in a direction x on a second stage and (c) is indicating resonance in a direction y on a third stage,

Fig. 4 is a diagram for illustrating how the coupling can be varied in the event of varying the size of the ridge portion to be chamfered, (a) is showing a graph indicating the result and (b) is showing how to take a size C of the ridge portion to be chamfered and a size L of whole surface including the above-mentioned chamfered portion,

Fig. 5 is a perspective diagram for showing a dielectric filter of the example 1 utilizing a triple mode dielectric resonator,

Fig. 6 is a diagram for showing an example of characteristics of the dielectric filter shown in Fig. 5, (a) is showing a relation between insertion loss and return loss with frequency and (b) is showing a wide band characteristics of transmission loss,

Fig. 7 is a perspective diagram for showing a comparative example 1 of a dielectric filter with three stages utilizing conventional TE₁₁ δ mode,

Fig. 8 is a perspective diagram for showing a comparative example 2 of a dielectric filter utilizing conventional HE₁₁ δ dual mode,

Fig. 9 is showing pass band characteristics of the dielectric filter of the comparative example 2 shown in Fig. 8,

Fig. 10 is a perspective diagram for showing a dielectric filter of an example 2 utilizing two triple mode dielectric resonators,

Fig. 11 is a perspective diagram for showing a dielectric filter of an example 3 providing a dielectric filter utilizing two triple mode dielectric resonators with a metallic partition between two dielectric blocks,

Fig. 12 is a diagram for showing a frequency characteristic of the dielectric filter shown in Fig. 11,

Fig. 13 is a diagram showing a method of adjusting the dielectric filter by using a metal rod,

5 Fig. 14 is a perspective diagram for showing a dielectric filter with eight stages relative to the example 5 consisting of a combination of a triple mode dielectric resonator of the present invention and a metallic TEM mode resonator,

Fig. 15 is a diagram for illustrating a triple mode
10 dielectric resonator relative to a second preferred embodiment of the present invention, (a) is a diagram for showing a basic composition of the triple mode dielectric resonator, (b) is a diagram for showing planes existing each electric field of the triple mode resonance in the dielectric resonator and (c) is a
15 diagram for showing a method of exciting a single mode (in other word, exciting in a degenerated state) in the dielectric resonator,

Fig. 16 is a diagram for showing pass band characteristics and return loss in the event of exciting a single mode (in other
20 word, exciting in a degenerated state) as shown in Fig. 5 (c),

Fig. 17 is a diagram for showing a dielectric resonator of an example 1, (a) is a perspective view of the dielectric resonator observed from a certain point of view and (b) is a perspective view of the dielectric resonator observed from
25 another point of view,

Fig. 18 is a diagram for showing a composition of the dielectric filter mounting a dielectric resonator of the example 1 therein,

Fig. 19 is showing pass band characteristics and return

loss of a dielectric filter shown in Fig. 18,

Fig. 20 is a diagram for showing a dielectric resonator of the example 2, (a) is a perspective view of the dielectric resonator observed from a certain point of view and (b) is a perspective view of the dielectric resonator observed from another point of view.

Fig. 21 is a diagram for showing a relation between a dielectric resonator and a feeding probe of the example 3,

Fig. 22 is a diagram for showing a relation between a dielectric resonator and a feeding probe of an example 4, (a) is a diagram for showing main portion of the dielectric filter of the example 4 and (b) is a diagram for showing an installing position of the feeding probe,

Fig. 23 is a diagram for showing attenuation characteristics of the dielectric filter of the example 4 and

Fig. 24 is a diagram for illustrating an event of using plural dielectric resonators, (a) is a diagram for showing an example 5 using two dielectric resonators and (b) is a diagram for showing an example 6 applying four dielectric resonators to a duplexer.

[Preferred Embodiment for carrying out the Present Invention]

Referring to the drawings, explanation will be made for describing the present invention in detail, as follows.

At first, a first preferred embodiment of the present invention is described. Fig. 1 is a perspective diagram for showing a triple mode dielectric resonator relative to a first preferred embodiment of the present invention. The triple mode dielectric resonator relative to the present preferred

embodiment is composed of combination of three resonant modes in one dielectric block 1 by having a surface 2a formed by chamfering a ridge portion of a dielectric block 1 of a generally rectangular parallelepiped and a surface 2b formed by chamfering another ridge portion which is not parallel to the above-mentioned ridge portion. Incidentally, though axes x, y, z is shown separately from the dielectric block 1 in Fig. 1, the axes x, y, z are in a relation to be orthogonal to each of two surfaces of the dielectric block 1 of a generally rectangular parallelepiped. And the relation is taken over in the following drawings.

That is, now, in the orthogonal x-y-z coordinate system, the electric field is excited initially so that a direction z corresponds to a propagation direction of TE wave. Then an electric field repeats reflections in the direction z by 180-degrees reflection of the electric field at an interface surface of the dielectrics and the air and excites resonance of rectangular TE₁₁₀ mode at a certain frequency shown in Figs. 2 (a) and (b). However, as shown in Fig. 1, when the dielectric block 1 has the surface 2a which is formed by chamfering a ridge portion parallel to the axis y, a tangent component (component y) of the electric field reflects in a 90-degrees direction on the surface 2a and propagates in the direction x. That is, component y in the propagation direction z reflects on the surface 2a and becomes component y in the propagation direction x. Electric wave generated in the direction x also repeats reflections at the interface surface similar to the direction z and excites resonance. According to the similar principle, when the dielectric block 1 has the surface 2b which is formed by

chamfering a ridge portion parallel to the axis z , resonance in the direction y is excited and three resonance are excited successively by one resonator. What described above is the principle of the combination. Though the actual electric field in a resonator are degenerated so that components in three directions can exist concurrently, it is understandable that the direction z is on a first stage, as shown in Fig. 3 (a), the direction x is on a second stage, as shown in Fig. 3 (b), the direction y is on a third stage, as shown in Fig. 3 (c). When the dielectric block is a cube, resonant frequency on the second stage is raised higher. For adjusting three resonance frequencies, the size of the dielectric block 1 can be shortened on the second stage, that is, in the direction x . And with regard to the coupling, it can be understood that the surface 2a with a chamfered ridge portion is a coupling of the first and the second stages and the surface 2b with a chamfered ridge portion is a combination of the second and the third coupling.

The result of checking for how the coupling varies in the event of changing the size of chamfering the above-mentioned ridge portion is shown in Fig. 4. Here, by taking a size C of the chamfered ridge portion of the dielectric block 1 of a generally rectangular parallelopiped and a size L of the whole surface including the chamfered portion, variation of coefficients of coupling is checked for in four events of varying C/L . As shown in Fig. 4 (a), as an occupied rate of the size L of the whole by the size C of the chamfered ridge portion goes up, so does the coefficients of the coupling monotonously. Therefore, the coupling can be intensified, as the size of the chamfered ridge portion is taken larger in the dielectric block 1.

(Example 1)

Fig. 5 is a perspective diagram of a dielectric filter of an example 1 in which one of the above-mentioned triple mode dielectric resonator is used. That is, as shown in Fig. 5, the dielectric filter of the present example is composed of a triple mode dielectric resonator 50 disposed in a cut-off wave guide 3, in which three resonant modes of a dielectric block 1 of a generally rectangular parallelepiped are coupled by forming a surface 2a by chamfering a ridge portion and a surface 2b by chamfering a ridge portion on the dielectric block 1 and two rod-type antennas 8, 8 having a tip respectively opened by input-output terminals 9, 9 are provided as means for excitation. In the dielectric filter of the example 1, the antennas 8, 8 with an open tip are used as means for excitation of the dielectric resonator 50. Actually, the dielectric resonator 50 is supported by dielectrics with low dielectric constant, and the like in order not to contact with the cut-off waveguide 3, while the dielectrics with low dielectric constant is abbreviated in the present diagram. Characteristics example of the dielectric filter shown in Fig. 5 is shown in Figs. 6 (a) and (b). As shown in Fig. 6 (a), three poles of return loss appear and that indicates characteristics corresponding to the characteristics of a filter with three stages is obtained. And as shown in Fig. 6 (b), it is apparent that two attenuation poles 62, 64 are generated on a side of higher frequency than center frequency.

(Comparative Example 1)

Fig. 7 is a perspective diagram for showing a comparative

example 1 of a dielectric filter with three stages using a conventional $TE_{11\delta}$ mode. That is, the dielectric filter of the comparative example 1 is composed of three dielectric blocks 1 putting a predetermined distance to each other disposes in a longitudinal cut-off waveguide 3 and rod-type antennas 8, 8 having a tip respectively opened by input- output terminals 9, 9 provided as means for excitation at both ends in a longitudinal direction of the cut-off waveguide 3. And screws 4, 4 having one end respectively contacting with the cut-off waveguide 3 are disposed between each of three dielectric blocks 1 in order to adjust the coupling between the dielectrics. Incidentally, 40 indicates mounts for supporting each resonator (dielectric block 1) and resonant frequency of each resonator (dielectric block 1) is adjusted by each metal rod 42.

With regard to volume of the dielectric block 1, the dielectric filter according to the example 1 shown in Fig. 5 is larger to some extent than the one according to the comparative example 1 shown in the above-mentioned Fig. 7, though a certain amount of distance corresponding to the coupling is required between a dielectric block 1 and another dielectric block 1, as shown in Fig. 7. As characteristics corresponding to a filter with triple stages can be obtained by one dielectric block 1 in the dielectric filter according to the example 1 shown in Fig. 5, the above-mentioned distance is not required and the volume of whole filter is possibly one third of the comparative example 1. As mentioned above, in the example 1, it is possible for realizing a small dielectric filter using a triple mode dielectric resonator. (Comparative Example 2)

Fig. 8 is a perspective diagram for showing a comparative

example 2 of a dielectric filter using a conventional HE₁₁ δ dual mode. That is, the dielectric filter is composed of a cylindrical dielectric block 1 supported by dielectrics with low dielectric constant, and the like (not shown) in order not to contact with a cut-off waveguide 3 disposed in the cylindrical cut-off waveguide 3 and rod-type antennas 8, 8 having a tip respectively opened by input-output terminals 9, 9 provided at both ends of the cut-off waveguide 3 varying the angles to each other. Two resonance in the dual mode dielectric resonator are adjusted with the coupling by a metal rod 13. Pass band characteristics of the dielectric filter of the comparative example 2 shown in Fig. 8 are shown in Fig. 9. Incidentally, Fig. 9 shows the same band as the Fig. 6.

As shown in reference numeral 92 of Fig. 9, undesired resonance is excited near the high frequency side of the pass band in the dielectric filter of the comparative example 2. On the contrary, in the dielectric filter according to the example 1 mentioned above, abrupt attenuation poles 62, 64 are generated on the high frequency side of the pass band, which appears the dielectric filter has excellent characteristics as a filter. (Example 2)

Fig. 10 is a perspective diagram of a dielectric filter of an example 2 utilizing two of the above-mentioned triple mode dielectric resonators therein. That is, the dielectric filter of the example 2 is composed of two of the triple mode dielectric resonators shown in Fig. 1 putting a predetermined distance to each other disposed in a longitudinal cut-off waveguide 3 and rod-type antennas 8, 8 having both end surfaces opened by input-output terminals 9, 9 provided in a direction of axis x

from the above-mentioned both end surfaces in longitudinal direction of the cut-off waveguide 3 respectively. And a screw 4 contacting with upper surface of the cut-off waveguide 3 by one end is disposed between the two triple mode dielectric resonators in order to adjust the coupling between the dielectrics. Incidentally, mounts for supporting each resonator (dielectric block 1) are abbreviated in the present diagram as well.

In the dielectric filter of the example 2, two of the triple mode dielectric resonators are provided, which makes totally six stages of filter. In Fig. 10, a metal rod (screw) 4 is inserted between the resonators in order to couple the two dielectric resonators strongly by resonance in the direction y.

(Example 3)

Fig. 11 is a perspective diagram of a dielectric filter of an example 3 which is a dielectric filter utilizing the above-mentioned triple mode dielectric resonators providing a metallic partition 5 between two dielectric blocks 1 therein. That is, in the same manner as the above-mentioned example 2, the dielectric filter of the example 3 is composed of two of the triple mode dielectric resonators shown in Fig. 1 disposed in a longitudinal cut-off waveguide 3 and rod-type antennas 8, 8 having both end surfaces opened by input-output terminals 9, 9 provided in a direction of axis x from the above-mentioned both end surfaces in longitudinal direction of the cut-off waveguide respectively. In the present example, a metallic partition 5 is provided instead of a screw 4 of the example 2 between the two dielectric resonators. And as shown in Fig. 11, a surface 2b having the above-mentioned another ridge portion chamfered on

one side of the dielectric block 1 is formed in a different position from the surface of the example 2 shown in Fig. 10. Incidentally, mounts for supporting each resonator (dielectric block 1) are abbreviated in the present diagram as well.

5 A frequency characteristic of the dielectric filter is shown in Fig. 12. In the dielectric filter of the example 3, a coupling between resonators by resonance in direction x and direction z can be weakened by the metallic partition 5 and the coupling between the resonators can be mainly obtained by the resonance
10 in direction y . And it is possible for providing an attenuation pole in any position arbitrarily by varying the position of the metallic partition 5 and the direction of each dielectric block 1. As shown in Fig. 12, attenuation poles 122, 124 can be provided respectively on both of low frequency side and high frequency
15 side of the pass band by using a shape of resonator of the example 3 shown in Fig. 11, means for excitation and metallic partition 5.

(Example 4)

Fig. 13 is a diagram for showing a method of adjusting the
20 above-mentioned dielectric filter by a metal rod. Actually, a screw is used as a metal rod and the adjustment is conducted by putting in and out of the screw. The metal rod acts on a magnetic field leaking from dielectrics. As the metal rod in the position of 6a in Fig. 13 has interlinkage with magnetic flux of
25 the resonance in the event of resonance in direction x , the magnetic field is intensified and resonant frequency becomes lower. The phenomenon is equal to a growth of equivalent inductance in a parallel resonant circuit. In the same manner, 6b lowers the resonant frequency of y direction.

Conventionally, as a metal rod in a position of 6c raises the resonant frequency, frequency can be adjusted in wide range by combination of the adjustment in the three directions x, y, z. With regard to the coupling, as 7a weaken the coupling of resonance in direction x and in direction y while 7b works for intensifying the coupling, adjustable range is wide. As mentioned above, because of a post-adjustment by using a metal rod, a precision required for sizes or dielectric constant of a dielectric block in manufacturing a resonator can be alleviated and manufacturing cost can be saved in the result.

(Example 5)

Fig. 14 is a perspective diagram for showing a dielectric filter with eight stages composed of combination of a triple mode dielectric resonator of the present invention and a TEM mode resonator made of metal relative to an example 5. That is, the dielectric filter of the example 5 is composed of two of the triple mode dielectric resonators shown in Fig. 1 putting a predetermined distance to each other disposes in a cut-off waveguide 3 and a TEM mode resonator 41 made of metal disposed on both sides of the resonators. Incidentally, rod-type antennas 8, 8 opened by input-output terminals 9, 9 are provided in a direction of axis y at both end portions of the cut-off waveguide 3. In the present invention, totally three metallic partitions 5 are provided between the two triple mode dielectric resonators and between each triple mode dielectric resonator and the TEM mode resonator 41. Incidentally, mounts for supporting each resonator are abbreviated in the present diagram as well. When a filter is manufactured by using only a triple mode dielectric resonator, the filter can be

composed of stages by multiples of three, however, a filter composed of stages of arbitrary numbers can be composed by combining the triple mode dielectric resonator of the present invention and, for example, a resonator of single TE₀₁ δ mode of dielectrics according to a prior art, and the like. And as shown in Fig. 14, undesired resonance can be suppressed by combining the TEM mode resonator 41 instead.

Next, a second preferred embodiment of the present invention will be described as follows.

Fig. 15 (a) is a diagram for showing a fundamental composition of a triple mode dielectric resonator relative to the second preferred embodiment of the present invention and Fig. 15 (b) is a diagram for showing planes existing each electric field of the triple mode resonance in the dielectric resonator shown in Fig. 15 (a).

As shown in Fig. 15 (a), the dielectric resonator 10 of the present preferred embodiment consists of dielectric blocks generally cube-type with three ridge portions chamfered and characterized in generating TE₀₁ δ mode in electro-magnetically independent three surfaces m1, m2, m3 of the dielectric block, as shown in Fig. 15 (b). Incidentally, the electro-magnetically independent three resonant modes are generated on each surface of m1, m2, m3 and an angle of 60.0 degrees is offered between each surface of m1, m2, m3, in Fig. 15 (b).

Fig. 15 (c) is a diagram for showing a method of exciting a single mode (in other word, exciting in the degenerated state) in the dielectric resonator shown in Fig. 15 (a). As shown in Fig. 15 (c), feeding probes 24 and 25, for example, are disposed in the same direction on an opposing surface to the dielectric block to

excite a single mode.

Fig. 16 is a diagram for showing pass band characteristics in the event of exciting only a single mode (in other word, exciting in the degenerated state), as Fig. 15 (c). In Fig. 16, the pass band characteristics in the above-mentioned event is indicated by a solid line and return loss is indicated by a dotted line respectively.

As it is apparent from Fig. 16, all three resonant modes are TE₀₁ δ mode and have the similar resonant frequency of approximately 1.935 [GHz] in the triple mode dielectric resonator of the present preferred embodiment.

(Example 6)

Dielectric resonators of the present example are shown in Figs. 17 (a) and (b). Figs. 17 (a) and (b) are diagrams for showing the same dielectric resonator 10 observed from different viewpoints respectively. Incidentally, a dielectric block consisting of dielectric materials of BaO-TiO₂ system providing relative dielectric constant ϵ_r of 37 is used in the dielectric resonator 10 of the present example.

For manufacturing the dielectric resonator 10 of the present example, three ridge portions sharing one point of a dielectric block consisting of a cube with a side of 22mm (22mm x 22mm x 22mm) are chamfered in order to offer an angle of 45 degrees to the surface of the dielectric block and each surface of A1, A2, A3 and each surface of A1, A2, A3 is formed in plane having a width of approximately 7mm respectively, as shown in Fig. 17 (a). As a result, there are portions of the three surfaces of the original cube remained non-chamfered and a surface B1 adjacent to the surfaces A2, A3, a surface B2

adjacent to the surfaces A1, A3 and a surface B3 adjacent to the surfaces A1, A2 are respectively formed. The surfaces B1, B2, B3 are squares with a side of 17mm (17mm x 17mm). Therefore, in the present example, area ratios of the surfaces A1, A2, A3 with respect to the surfaces B1, B2, B3 respectively are approximately 45%.

Further, as shown in Fig. 17, each of surfaces C (surface C2 opposing to surface B1, surface C1 opposing to surface B3, surface C3 opposing to surface B2) opposing to the surfaces B is shaped in a square with a side of 22mm (22mm x 22mm) having one corner clipped by an isosceles triangle with two sides of 5mm and one side of 7mm. Though the portion in which the surfaces A (A1, A2, A3) transposition is formed in a triangular cone, there is no problem in the characteristic to chamfer the triangular cone portion to be plane.

Fig. 18 is a diagram for illustrating a dielectric filter 20 mounting the dielectric resonator 10 of the example 1 in a cut-off waveguide 21 of a generally rectangular parallelepiped. Incidentally, though axes x, y, z are shown separately from the dielectric resonator 10 in Fig. 18, each of axes x, y, z is in relation orthogonal to each of two surfaces of the dielectric block of the original cube of the dielectric resonator 10. The same thing takes place in the following drawings. The dielectric filter 20 is formed by disposing the dielectric resonator 10 shown in Figs. 17 (a) and (b) in a cut-off waveguide 21 of a generally rectangular parallelepiped which is manufactured by processing copper (Cu) plates with thickness of 1mm or by grinding aluminum (Al) block to be with thickness of 3mm. Incidentally, as shown in Fig. 18, the dielectric filter 20

provides feeding probes 22, 23 disposed at two positions therein. A rod-type material is used as feeding probes 24, 25. Direction p (not shown) of the two feeding probes 24 and 25 is parallel to the axis x with respect to axes x, y, z of the dielectric resonator 10, therefore, an angle p' (not shown) offered by the feeding probes 24 and 25 is 0 degree.

In Fig. 19, pass band characteristics of the dielectric filter 20 is indicated by a solid line and return loss is indicated by a dotted line, respectively.

As shown in Fig. 19, dielectric filter 20 of the present example has a pass band between 1.916 [GHz] and 1.934 [GHz], both inclusive. Further, in Fig. 19, poles of return loss 51, 52, 53 indicate that a three-stage band pass filter is formed by the dielectric filter 20 of the present example.

(Example 7)

A dielectric resonator 11 of the present example is shown in Figs. 20 (a) and (b). Figs. 20 (a) and (b) are diagrams of the same dielectric resonator 11 observed from different points of view respectively. Incidentally, a dielectric block consists of dielectric material of BaO-TiO₂ system providing relative dielectric constant ϵ_r of 37 is used in the dielectric resonator 10 of the present example in the same manner as the example 1.

The dielectric resonator 11 of the present example has three surfaces A (A1, A2, A3) formed by chamfering three ridge portions sharing one point of a dielectric block, as shown in Fig. 20 (a) and three surfaces A'4, A'5, A'6 (hereafter called surfaces A') further formed by chamfering three ridge portions sharing another point on diagonal line of the above-mentioned point.

And in the present example, an angle offered by the three surfaces A or by three surfaces A' with other adjacent three surfaces B'1, B'2, B'3 [refer to Fig. 20 (a)] (hereafter called as surfaces B') or with other adjacent three surfaces C'1, C'2, C'3 [refer to Fig. 20 (b)] (hereafter called as surfaces 'C') respectively is 45 degrees.

For manufacturing a dielectric resonator 11 of the present example, three ridge portions sharing one point of a dielectric block consisting of a cube with a side of 22mm (22mm x 22mm x 22mm) is chamfered so that the surface of the dielectric block and surfaces A1, A2, A3 offers 45 degrees respectively and each of the surfaces A1, A2, A3 is formed in plane with a width of 7mm, as shown in Fig. 20 (a).

Further, three ridge portion sharing another point on a diagonal line of the above-mentioned point is chamfered so that the surface of the dielectric block and surfaces A4', A5', A6' offers 45 degrees respectively and each of the surfaces A4', A5', A6' is formed in plane with a width of 7mm, as shown in Fig. 20 (b). As the result, there are portions of the three surfaces of the original cube remained un-chamfered, a surface B'1 adjacent to the surfaces A2, A3, a surface B'2 adjacent to the surfaces A1, A3 and a surface B'3 adjacent to the surfaces A1, A2 are respectively formed and a surface C'1 opposing to the surface B'3, a surface C'2 opposing to the surface B'1 and a surface C'3 opposing to the surface B'2 are formed respectively. The surfaces B'1, B'2, B'3 are squares with a side of 17mm (17mm x 17mm) chamfered by one corner thereof. As the result that the corner of the surfaces B'1, B'2, B'3 is chamfered, the area ratio of the surfaces A with respect to the surfaces B' is

approximately 48% in the present example, which gets slightly larger than the above-mentioned example 1. And the areas and forms of the surfaces C' opposing to the surfaces B' are similar to the surfaces B'.

5 A similar dielectric filter can be formed by mounting the dielectric resonator 11 of the present example 7 in a cut-off waveguide of a generally rectangular parallelepiped, in the same manner as the example 6.

(Example 8)

10 A main portion of a dielectric filter of the present example is shown in Fig. 21. The dielectric filter of the present example is a dielectric filter mounting the dielectric resonator 10 similar to the one of example 6 shown in Figs. 17 (a) and (b) in a cut-off waveguide if a generally rectangular
15 parallelepiped, but only the dielectric resonator 10 and feeding probes 24 and 25 are shown in Fig. 21.

In the event that a direction p of the feeding probe 24 with respect to the axes x, y, z of the dielectric resonator 10 swings on a x-y surface and an angle θ_1 is 0 degree when the direction
20 p is parallel to the axis x, the direction p can be varied within the range between -45 degrees and +45 degrees, both inclusive, and in the event that a direction p' of the feeding probe 25 swings on a z-x surface and an angle θ_2 is 0 degree when the direction p' is parallel to the axis x, the direction p' can be
25 varied within the range between -45 degrees and +45 degrees, both inclusive. Incidentally, the angles are adjusted as $\theta_1=5$ degrees, $\theta_2=8$ degrees respectively in the present example.

(Example 9)

A main portion of a dielectric filter of the present

example is shown in Fig. 22 (a). The dielectric filter of the present example is a dielectric filter mounting the dielectric resonator 10 similar to the one of example 6 shown in Figs. 17 (a) and (b) in a cut-off waveguide of a generally rectangular parallelepiped, but only the dielectric resonator 10 and feeding probes 24 and 25 are shown in Fig. 22 (a).

In the present example, the feeding probes 24 and 25 are provided on the surfaces B [the surfaces B2 in Fig. 17 (a)] and the surfaces C [the surfaces C2 in Fig. 17 (b)] of the dielectric resonator 10. Positions for disposing the feeding probes 24 and 25 are shown in Fig. 22 (b). Fig. 22 (b) is a diagram of the dielectric resonator 10 and the feeding probes 24 and 25 observed from a direction of axis x. Directions p (not shown) and p' (not shown) of the feeding probes 24 and 25 are parallel to the axis x, as shown in Fig. 22 (b) and the feeding probes 24 can be displaced in parallel with the axis y and the feeding probes 25 can be displaced in parallel with the direction of axis z, as shown in Fig. 22 (b).

In Fig. 22 (b), movement of the feeding probes 24 and 25 to approach to each other is indicated as a (refer to the diagram). Here, as shown in Fig. 22 (b), the amount is indicated as $a=0$ in the event that the feeding probes 24 and 25 are positioned respectively on a centerline of the dielectric resonator 10.

In the present example, attenuation characteristics are measured in the following three events that the feeding probes 24 and 25 are positioned respectively on the center line of the dielectric resonator 10 [$a=0$], that the feeding probes 24 and 25 move 1mm in a direction of approaching to each other [$a=1$] and that the feeding probes 24 and 25 move 1mm in a direction of

leaving to each other $[a=-1]$. In Fig. 23, the attenuation characteristics of the dielectric filter of the present example are shown. At first, as shown in the diagram, in the event of $a=0$, an attenuation pole 90 is generated at frequency of approximately 1.873 [GHz]. Thus, the attenuation pole is obtained on a side of lower frequency than a center frequency, that is, on a lower side band. And it is appeared that in the event that the feeding probes 24 and 25 move in the direction of approaching 1mm to each other $[a=1\text{mm}]$, the attenuation pole 90 is generated at a frequency of approximately 1.805 [GHz], that is, it moves to the side of lower frequency, comparing to the event of $a=0$. On the contrary, in the event that the feeding probes 24 and 25 move in the direction of leaving 1mm to each other $[a=-1\text{mm}]$, the attenuation pole 90 is generated at a frequency of approximately 1.90 [GHz], that is, it moves to the higher frequency side, comparing to the event of $a=0$.

(Example 10)

In the examples 6 through 9 above, examples using only one dielectric resonator are described, but in the present example, as shown in Fig. 24, two of the dielectric resonators 10 are used and a dielectric filter 100 with six stages are formed. At the time, there are two feeding probes and the characteristics thereof can be varied in the same manner as described in the examples 8 and 9.

And though it is not shown in the diagram, it is also acceptable to use three or more dielectric resonators 10 and the characteristics of the dielectric filter can be varied by varying the position or angle of the feeding probe.

(Example 11)

The present example is an example using four dielectric resonators 10, as shown in Fig. 24 (b). The present example is an example for applying a dielectric filter 150 combined for transmitting and for receiving using two dielectric resonators 10 and a duplexer 200 is composed.

While specific preferred embodiments of the present invention have been described above, it will be understood that the present invention is not limited and can be applied to other preferred embodiments within the scope of invention claimed therein.

For example, though a rod-type antenna is used as a feeding probe within the examples 6 through 9, the similar effect can be obtained by using loop antenna instead.

And though the angle offered by the three surfaces A formed by chamfering three ridge portions sharing one point of the dielectric block and another three surfaces B or B' adjacent thereto is set at 45 degrees, the similar effect can be obtained by an angle in the range between 40 degrees and 50 degrees, both inclusive. Further, though the angle offered by the three surfaces A' formed by chamfering three ridge portions sharing an apex of the dielectric block and another three surfaces C' adjacent thereto is set at 45 degrees, the similar effect can be obtained by an angle within the range between 40 degrees and 50 degrees, both inclusive.

Further more, though the area ratio of the surfaces A with respect to the surfaces B is set 45%, the similar effect can be obtained by an area ratio within the range between 1% and 200 %, both inclusive.

[Industrial Usability]

According to a first preferred embodiment of the present invention, it is possible to realize a triple mode dielectric resonator which is capable of acting as three resonators with one dielectric block, as described above. And by using the triple mode dielectric resonator, it is possible to achieve size reduction of dielectric filters. In the result of size reduction, weight and the number of required resonator can be reduced and the cost can be saved consequently. Besides, it is also effective for an arbitral positioning of an attenuation pole avoiding undesired resonance, and the like.

Further, as a dielectric resonator relative to a second preferred embodiment of the present invention has a dielectric block formed by chamfering three ridge portion of a generally rectangular parallelepiped and effects a degenerate coupling of the triple mode ($TE_{01\delta}$ mode) of the equal resonant frequency generated on three surfaces which are electro-magnetically independent of the above-mentioned dielectric block, it is possible for a very small dielectric resonator with a simple composition to be realized easily, while resonance of triple mode is available. And by mounting the dielectric resonator relative to the second preferred embodiment of the present invention, for example, in a cut-off waveguide of a generally rectangular parallelepiped and providing a feeding probe therein, a small sized dielectric filter with a simple composition can be provided.

What is claimed is;

1. A dielectric resonator characterized in that three resonant modes of a dielectric block of a generally rectangular parallelepiped are coupled by chamfering a ridge portion of said dielectric block and chamfering another ridge portion which is not parallel to said ridge portion at the same time.
2. A dielectric filter characterized in disposing at least one dielectric resonator claimed in claim 1 in a cut-off waveguide.
3. A dielectric filter claimed in claim 2 characterized in disposing two or more of said dielectric resonators in said and providing means for partition consisting of a conductive material between said dielectric resonators.
4. A dielectric filter claimed in claim 2 or 3 characterized in disposing a metal rod contacting with said cut-off waveguide by one end in parallel with a side surface of said dielectric resonator in the position distant a predetermined amount from said side surface and having a composition in which resonant frequency of each resonance and an amount of coupling between resonators is adjustable
5. A dielectric filter claimed in claim 2 through 4 characterized in installing other resonator further than dielectric resonator claimed in claim 1 in said cut-off waveguide.
6. A dielectric resonator characterized in comprising a

dielectric block in the form of a generally rectangular parallelepiped having three-ridge portions chamfered thereof and generating TE₀₁ δ mode on electro-magnetically independent three surfaces of said dielectric block.

5

7. A dielectric resonator claimed in claim 6 characterized in that said dielectric block is mounted in a cut-off waveguide of a generally rectangular parallelepiped.

10 8. A dielectric resonator claimed in claim 6 or 7 characterized in having three surfaces of A₁, A₂, A₃ (hereafter called surfaces A) formed by chamfering three ridge portions sharing a point of said dielectric block and three surfaces of B₁, B₂, B₃ (hereafter called surfaces B) adjacent to each of the
15 surfaces A respectively, in which an angle between 40 degrees and 50 degrees, both inclusive, is offered by said surfaces A and said surfaces B and an area ratio of said surfaces A with respect to said surfaces B stands between 1% and 200%, both inclusive.

20 9. A dielectric resonator claimed in claim 6 or 7 characterized in having three surfaces A formed by chamfering three ridge portions sharing an apex of said dielectric block, another three surfaces of A'₄, A'₅, A'₆ (hereafter called surfaces A') formed by chamfering three ridge portions sharing another
25 apex on a diagonal line of said apex, another three surfaces of B'₁, B'₂, B'₃ (hereafter called surfaces B') adjacent to each of surfaces A and surfaces A' respectively and still another three surfaces of C'₁ C'₂ C'₃ (hereafter called surfaces C') adjacent to each of surfaces A and surfaces A' respectively, wherein an

angle of 40 degrees through 50 degrees is offered by the surfaces A and B' or by the surfaces A' and C' and an area ratio of said surfaces A with respect to said surfaces B' or an area ratio of said surfaces A' with respect to said surfaces C' stand between
5 1% and 200%, both inclusive, respectively.

10. A dielectric filter using the dielectric resonator claimed in claim 8 or 9 characterized in that an angle between 40 degrees and 50 degrees, both inclusive, is offered by said three surfaces
10 A or A' formed by chamfering three ridge portions sharing an apex of said dielectric block and other three surfaces B or B' adjacent thereto respectively and the surfaces A or A' and surfaces B or B' adjacent thereto respectively have three opposing surfaces of C1, C2, C3 (hereafter called surfaces C) or
15 the surfaces C' and characterized in providing a feeding probe near the surfaces B and B', the surfaces B' and B', the surfaces C and C', or the surfaces C' and C'

11. A dielectric filter using the dielectric resonator claimed in claim 8 characterized in having said three surfaces A formed by
20 chamfering three ridge portion sharing an apex of said dielectric block, another three surfaces B adjacent to said three surfaces A offering an angle between 40 degrees and 50 degrees, both inclusive, and three surfaces C opposing to said three
25 surfaces B respectively, wherein a feeding probe is provided on the surfaces B and surfaces C.

12. A dielectric filter using the dielectric resonator claimed in claim 8 characterized in that an angle offered by a direction p

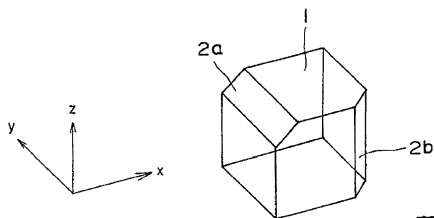
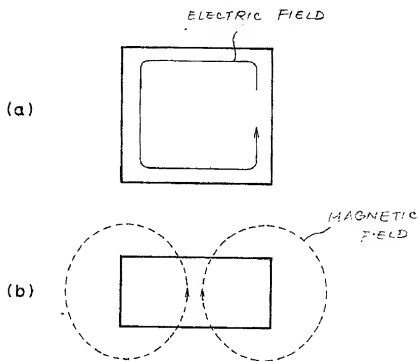
and p' of the feeding probe with respect to the x, y, z axes of said dielectric resonator are variable within the range between -45 degrees and +45 degrees, both inclusive, while in use.

- 5 13. A dielectric filter claimed in claim 11 characterized in that frequency and attenuation generating the attenuation pole at lower side band can be varied by varying a position for providing a feeding probe on said surfaces B and a position for providing a feeding probe on said surfaces C.
- 10 14. A dielectric filter claimed in claim 10 through 13 characterized in that said feeding probe is rod-type.
- 15 15. A dielectric filter claimed in claim 10 through 13 characterized in that said feeding probe is loop-type.
- 20 16. A dielectric filter using the dielectric resonator claimed in claim 7 through 9 characterized in mounting at least two or more of said dielectric resonators in said cut-off waveguide of a generally rectangular parallelepiped.

[Abstract]

A dielectric resonator (10) having three surfaces formed by chamfering three ridged portions sharing an apex of a dielectric block and another three surfaces adjacent respectively thereto, in which each of the chamfered surfaces and the adjacent surfaces thereto offers an angle of 45 degrees and an area ratio of the chamfered surfaces with respect to the adjacent surfaces is 45% is mounted in a cut-off waveguide of a generally rectangular parallelepiped (21) and feeding probe (24) and (25) are provided for composing a dielectric filter.

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**FIG. 1****FIG. 2**

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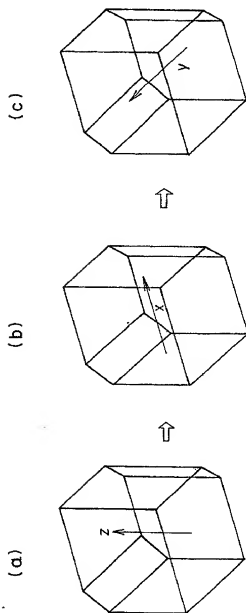


FIG. 3

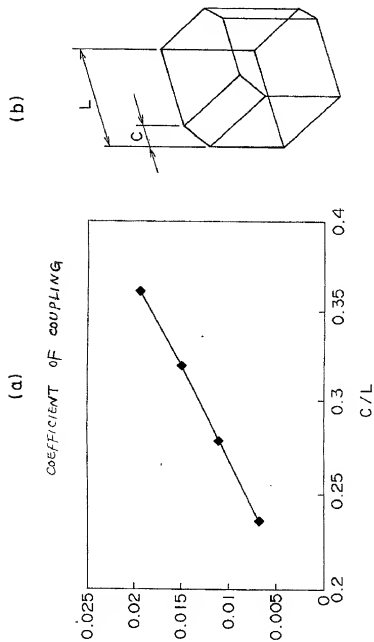


FIG. 4

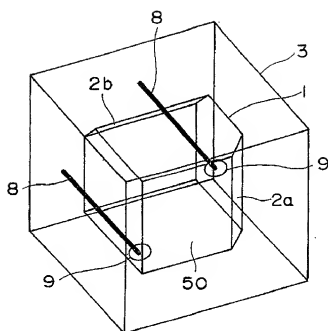


FIG. 5

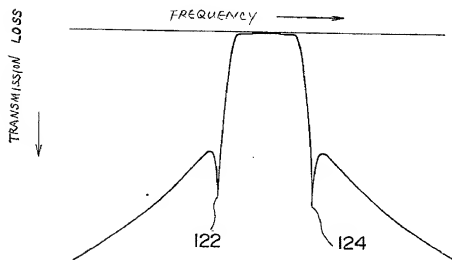


FIG. 12

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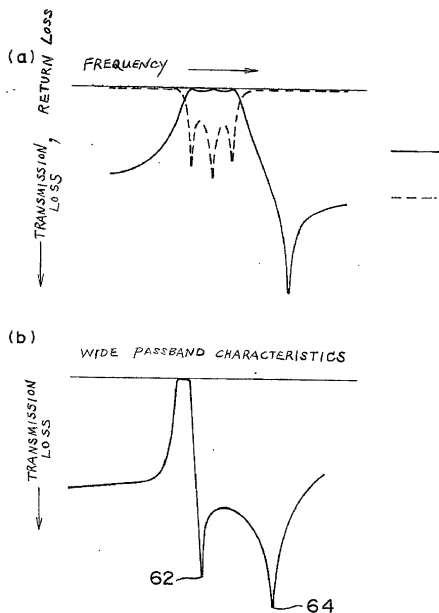


FIG. 6

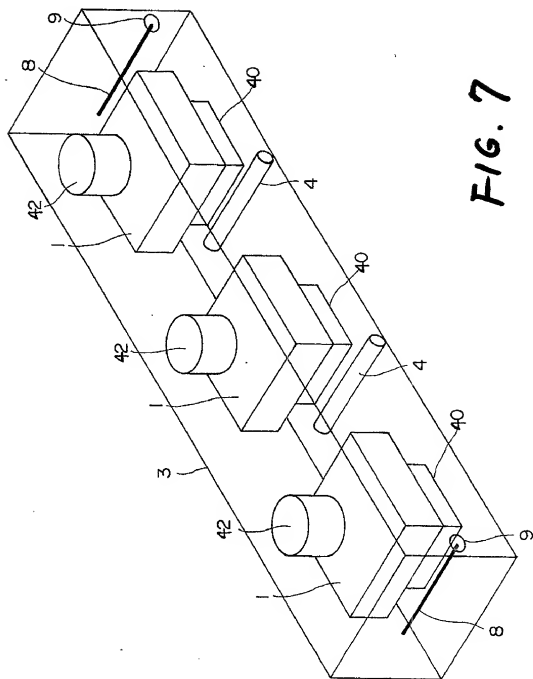


FIG. 7

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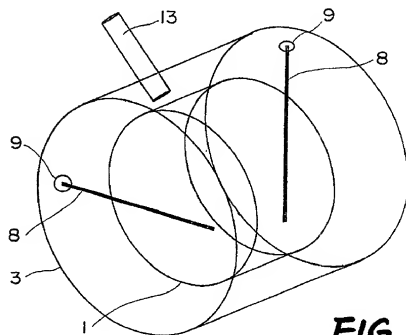


FIG. 8

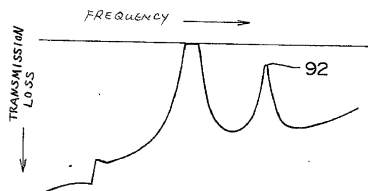
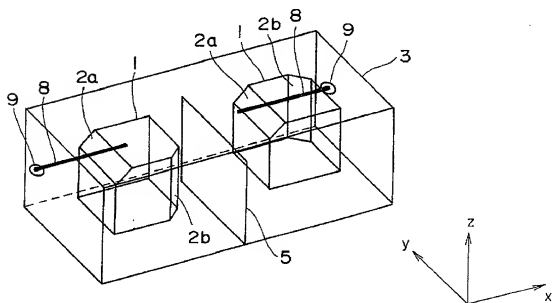
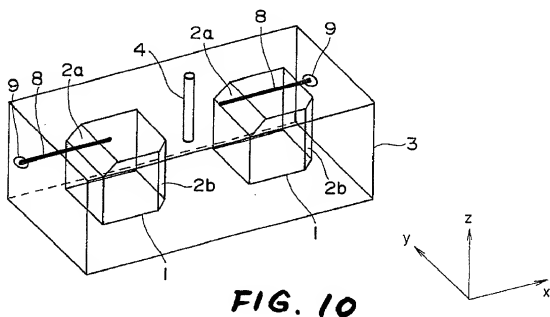


FIG. 9

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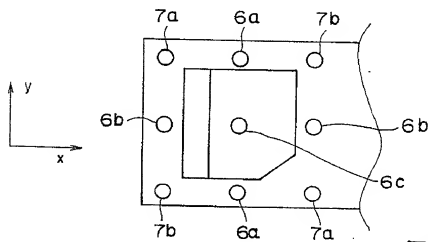


FIG. 13

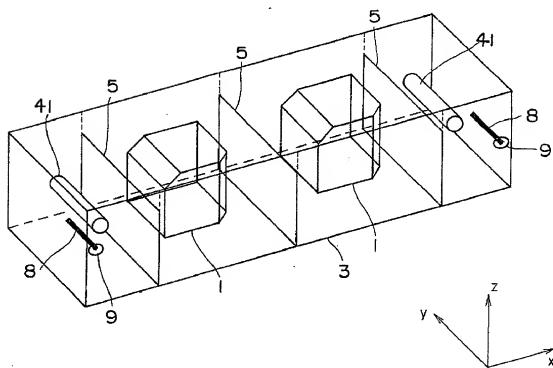


FIG. 14

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09/807819

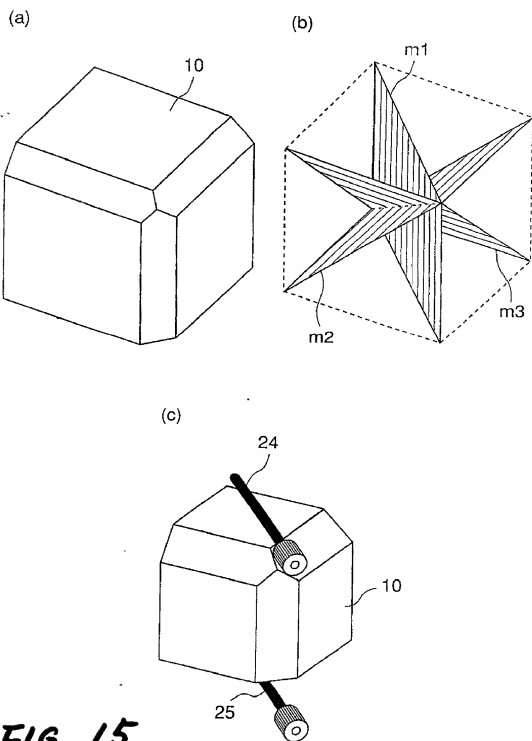


FIG. 15

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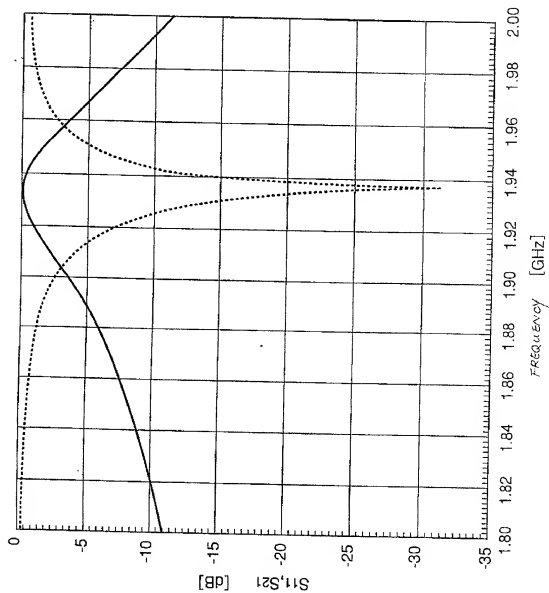


FIG. 16

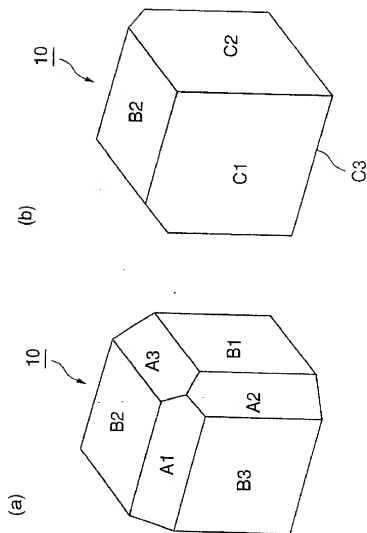


FIG. 17

09/807819

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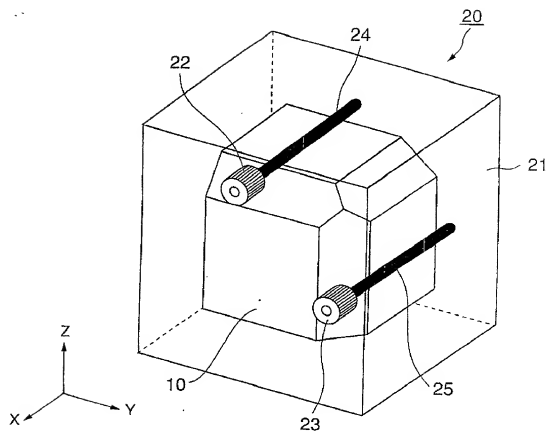


FIG. 18

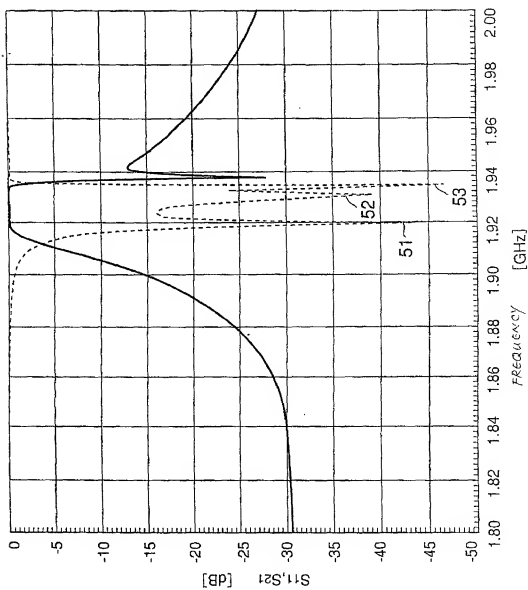


FIG. 19

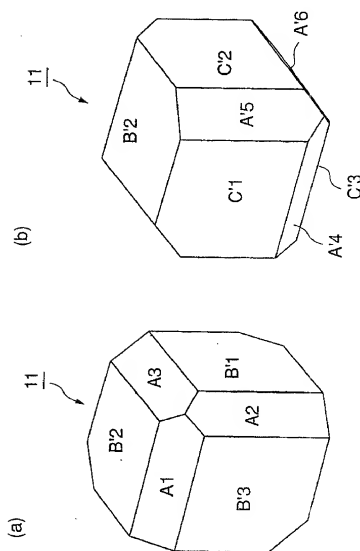


FIG. 20

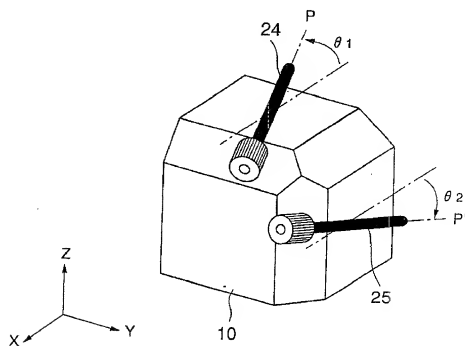


FIG. 21

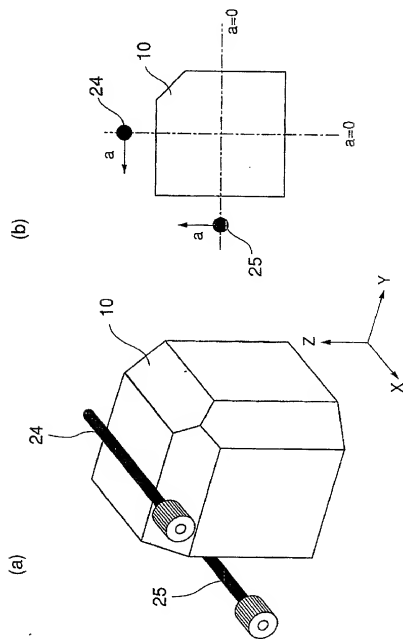


FIG. 22

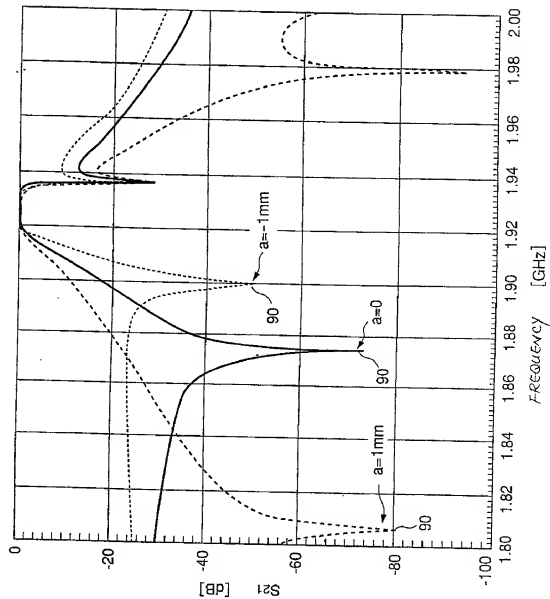
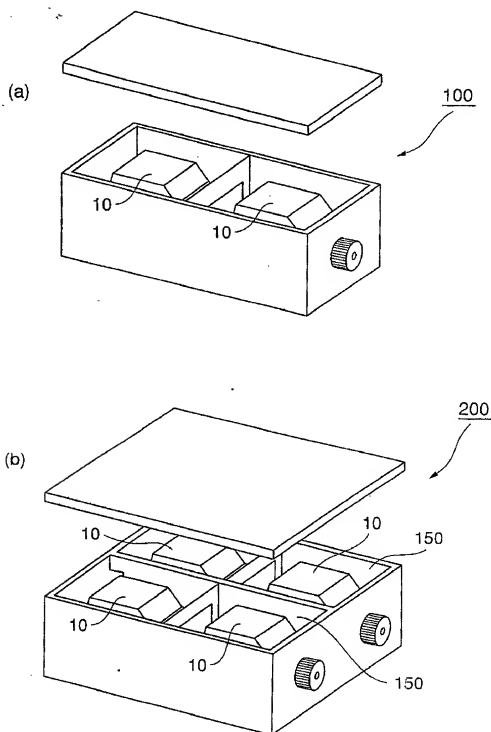


FIG. 23





DECLARATION AND POWER OF ATTORNEY

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name;

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled:

DIELECTRIC RESONATOR AND DIELECTRIC FILTER

the specification of which:
(check one)

 (is attached hereto)

X was filed on August 21, 2000,

as Application Serial No. PCT/IP00/05587

and was amended on April 19, 2001, (if applicable)

I hereby state that I have reviewed and understand the contents of the above identified specification, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations, § 1.56*

I hereby claim foreign priority benefits under Title 35, United States Code, § 119 of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

Prior Foreign Application(s)

			prior claimed	
<u>11-233683</u>	<u>Japan</u>	<u>20/08/1999</u>	<u>X</u>	
(Number)	(Country)	(Day/Month/Year Filed)	yes	no
<u>11-233684</u>	<u>Japan</u>	<u>20/08/1999</u>	<u>X</u>	
(Number)	(Country)	(Day/Month/Year Filed)	yes	no
<u> </u>	<u> </u>	<u> </u>	yes	no
(Number)	(Country)	(Day/Month/Year Filed)		

I hereby claim the benefit under Title 35, United States Code, § 120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, § 112, I acknowledge the duty to disclose material information as defined in Title 37, Code of Federal Regulations, § 1.56 which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

PCT/IP00/05587

(Application Serial No.)

21/August/2000

(Filing Date)

Pending

(Status: patented, pending, abandoned)

Power of Attorney: As a named inventor, I hereby appoint Sean M. McGinn, Reg. No. 34,386, and Frederick W. Gibb, III, Reg. No. 37,629, as attorneys and/or agents to prosecute this application and transact all business in the Patent and Trademark Office connected therewith. All correspondence should be directed to McGinn & Gibb, PLLC, 8321 Old Courthouse Road, Suite 200, Vienna, Virginia 22182-3817. Telephone calls should be directed to McGinn & Gibb, PLLC at (703) 761-4100.

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

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(An additional sheet(s) is/are attached hereto if the present invention includes more than four inventors.)

*Title 37, Code of Federal Regulations, § 1.56:

(a) A patent by its very nature is affected with a public interest. The public interest is best served, and the most effective patent examination occurs when, at the time an application is being examined, the Office is aware of and evaluates the teachings of all information material to patentability. Each individual associated with the filing and prosecution of a patent application has a duty of candor and good faith toward the Patent and Trademark Office, which includes a duty to disclose to the Office all information known to that individual to be material to patentability as defined in this section. The duty to disclose information exists with respect to each pending claim until the claim is canceled or withdrawn from consideration, or the application becomes abandoned.

(b) Under this section, information is material to patentability when it is not cumulative to information already of record or being made of record in the application, and (1) it establishes by itself or in combination with other information, a prima facie case of unpatentability; or (2) it refutes, or is inconsistent with, a position the applicant takes in: (i) opposing an argument of unpatentability relied on by the Office, or (ii) asserting an argument of patentability.